

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10089178	HIBINO ET AL.
	Examiner	Art Unit
	DEVONA E FAULK	2615

SEARCHED

Class	Subclass	Date	Examiner
381	86	5/31/06	BTP
381	86,302,102-109	4/26/07	DEF
381	86,302,102-109	5/19/08	DEF
455	345,569.2	5/20/08	DEF

SEARCH NOTES

Search Notes	Date	Examiner
Assignee/Inventor search	4/26/07	DEF
reviewed applicant's arguments, maintained rejection	10/18/07	DEF
additonal search	5/19/08	DEF

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner